

Notice of References Cited

Application/Control No.

09/311,753

Applicant(s)/Patent Under
Reexamination
INOUE ET AL.

Examiner

Kevin M Bernatz

Art Unit

1773

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Translation of Miyahara et al. (JP 08-020751 A)
	V	
	W	
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